## Notice of References Cited Application/Control No. 10/797,798 Applicant(s)/Patent Under Reexamination MYDLACK ET AL. Examiner Sang Nguyen Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,798,925	09-2004	Wagman, Adam	382/287
*	В	US-6,798,515	09-2004	Bachelder et al.	356/397
*	C	US-6,768,509	07-2004	Bradski et al.	348/207.99
*	D	US-6,594,623	07-2003	Wang et al.	703/1
*	E	US-6,061,126	05-2000	Yoshimura et al.	356/237.1
*	F	US-5,966,213	10-1999	Shimosaka et al.	356/613
*	G	US-5,467,192	11-1995	Manning, Kevin R.	356/613
*	Н	US-4,555,635	11-1985	Yoshida, Hajime	250/559.46
*	1	US-4,246,606	01-1981	Yoshida, Hajime	348/129
*	J	US-6,262,803	07-2001	Hallerman et al.	356/603
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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	Т					

## NON-PATENT DOCUMENTS

		NOTE ATEN DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.